

# Supporting Information

## Small magnetic nanoparticles decorating reduced graphene oxides to tune electromagnetic attenuation capacity

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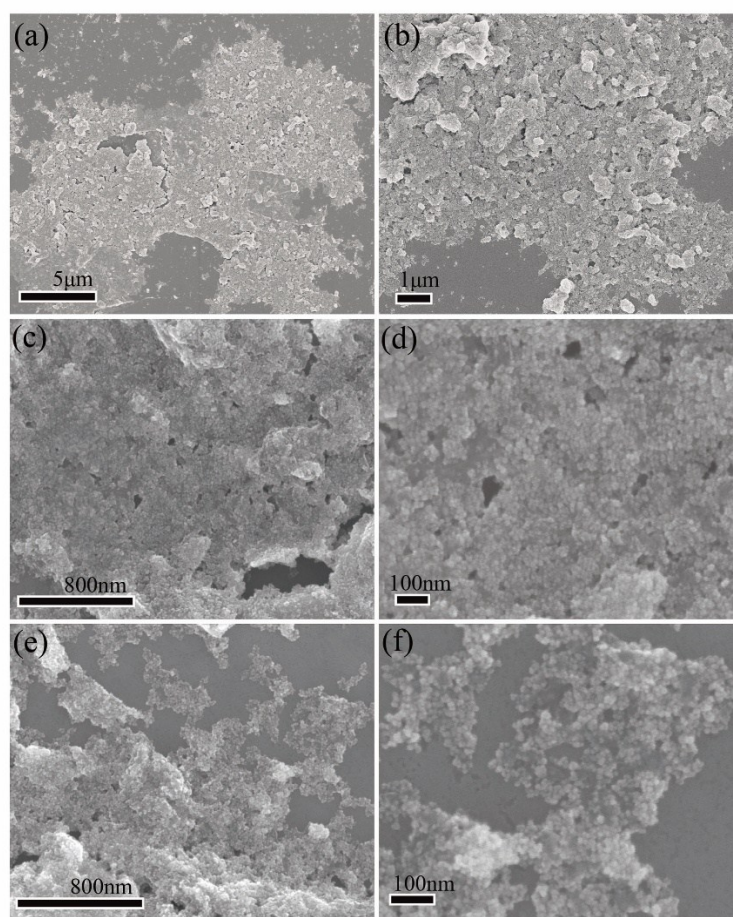


Fig.S1 The SEM images of NiFe<sub>2</sub>O<sub>4</sub>/r-GO.

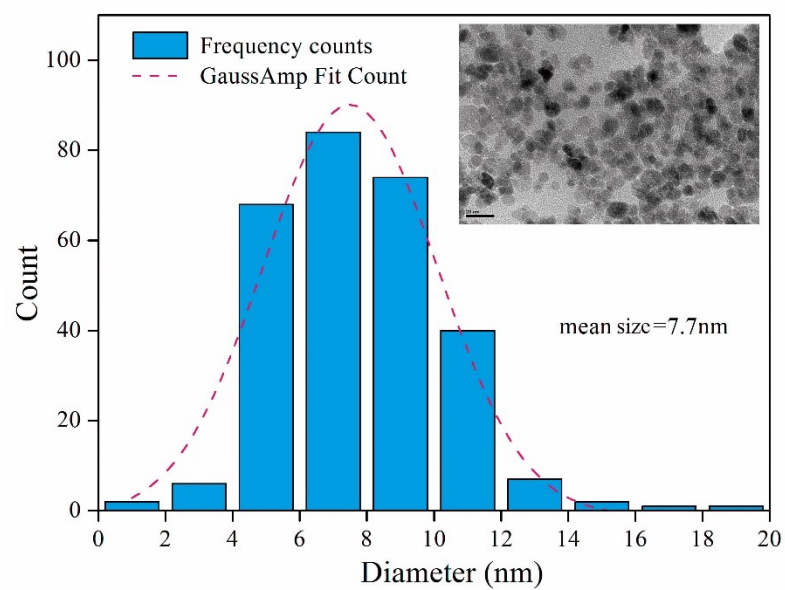


Fig.S2 Particle size distribution histogram of  $\text{NiFe}_2\text{O}_4$  nanoparticles from the inset.

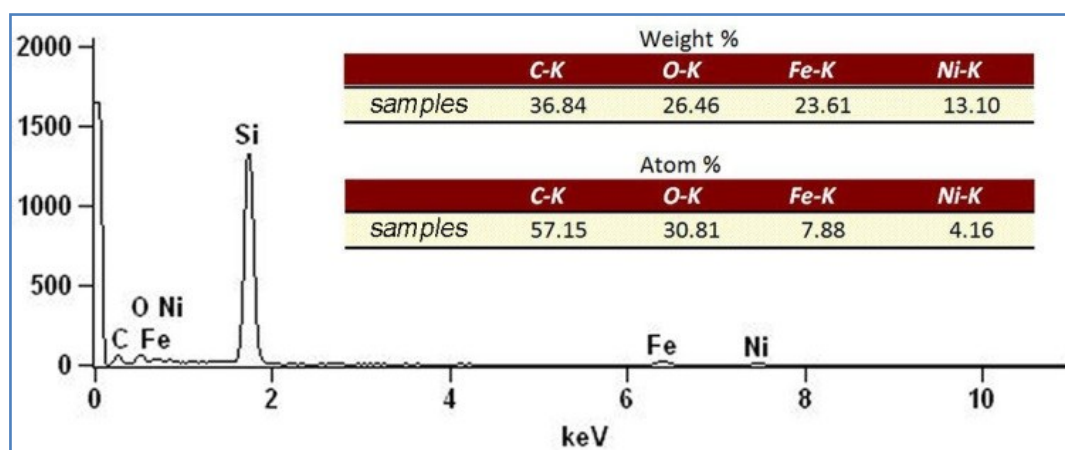


Fig.S3 The energy dispersive spectroscopy (EDS) analysis of NiFe<sub>2</sub>O<sub>4</sub>/r-GO samples; the mass percent and atom percent is in the inset

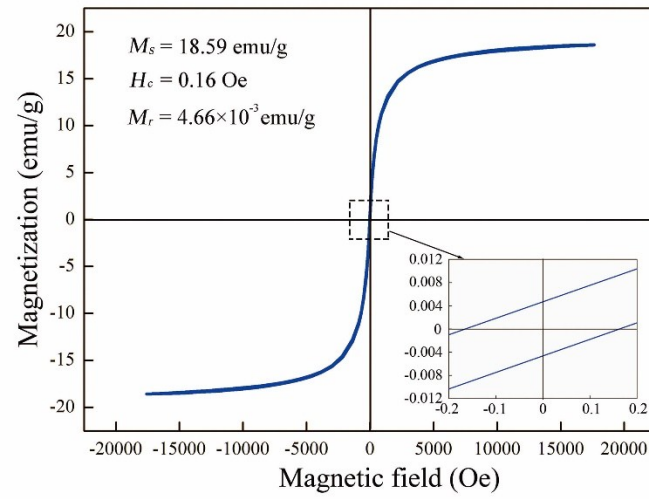


Fig.S4 Magnetic hysteresis loops for NiFe<sub>2</sub>O<sub>4</sub>/r-GO samples.

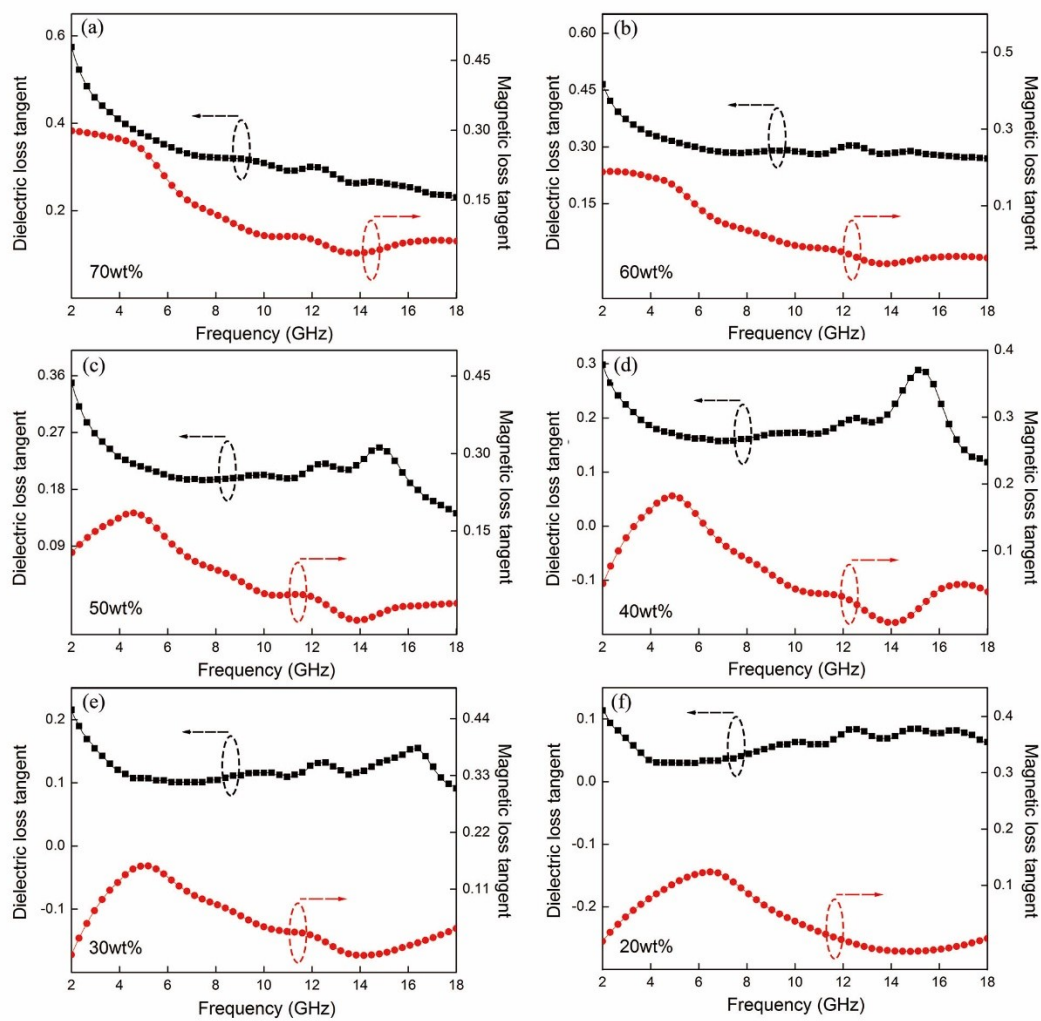


Fig.S5 Frequency dependence of the  $\tan \delta_e$  and  $\tan \delta_m$  of the samples with different NiFe<sub>2</sub>O<sub>4</sub>/r-GO loadings (a-f).

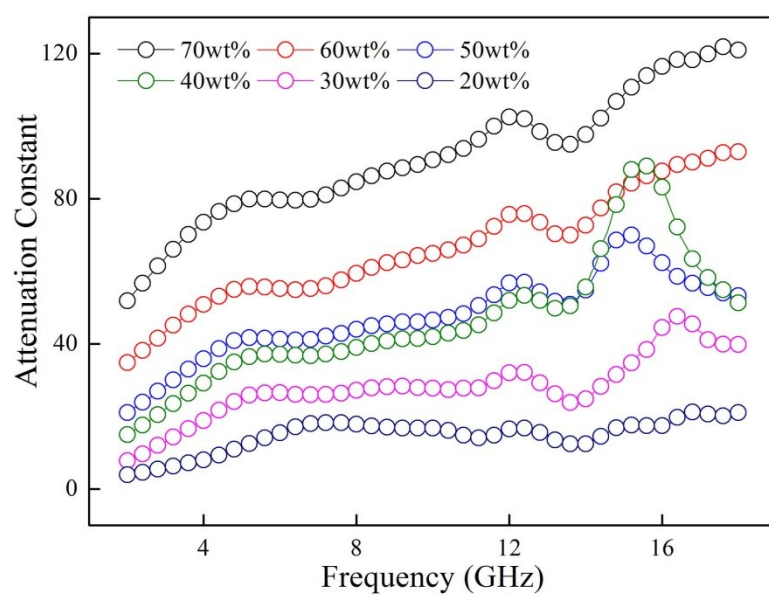


Fig.S6 Microwave attenuation constants ( $\alpha$ ) of the samples with different loadings

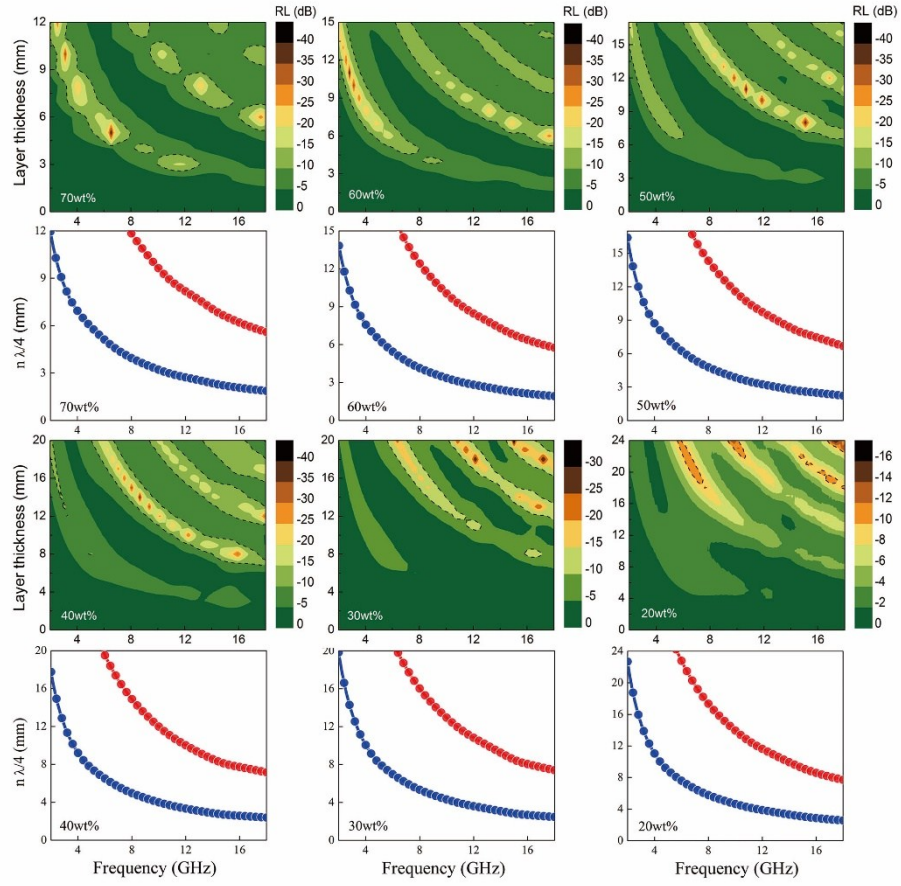


Fig.S7 Dependence of color maps of the reflection loss on frequency at various thickness and dependence of  $\lambda/4$  and  $3\lambda/4$  thickness on frequency for the samples with different  $\text{NiFe}_2\text{O}_4/\text{r-GO}$  loadings.